

Small switching (100V, 5A)

2SK2504

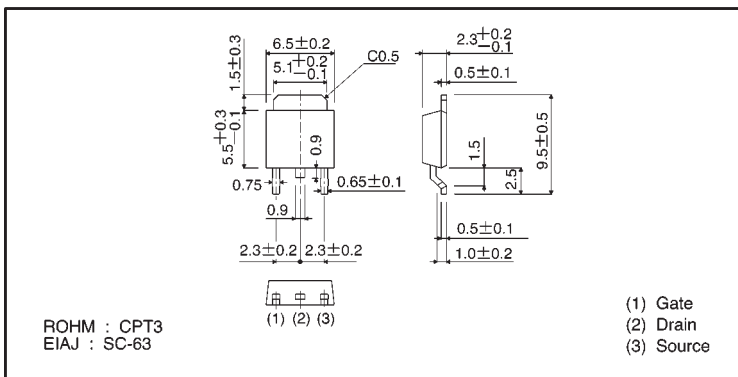
●Features

- 1) Low on-resistance.
- 2) Fast switching speed.
- 3) Wide SOA (safe operating area).
- 4) Low-voltage drive (4V).
- 5) Easily designed drive circuits.
- 6) Easy to parallel.

●Structure

Silicon N-channel
MOSFET

●External dimensions (Units: mm)



●Absolute maximum ratings (Ta = 25°C)

Parameter	Symbol	Limits	Unit
Drain-source voltage	V_{DS}	100	V
Gate-source voltage	V_{GS}	± 20	V
Drain current	Continuous	I_D	5
	Pulsed	I_{DP}^*	20
Reverse drain current	Continuous	I_{DR}	5
	Pulsed	I_{DRP}^*	20
Total power dissipation (Tc=25°C)	P_D	20	W
Channel temperature	T_{ch}	150	°C
Storage temperature	T_{stg}	-55~+150	°C

* $P_W \leq 10 \mu s$, Duty cycle $\leq 1\%$

●Packaging specifications

Type	Package	Taping
	Code	TL
	Basic ordering unit (pieces)	2500
2SK2504		○

●Electrical characteristics (Ta = 25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Gate-source leakage	I _{gss}	—	—	±100	nA	V _{GS} =±20V, V _{DS} =0V
Drain-source breakdown voltage	V _{(BR)DSS}	100	—	—	V	I _D =1mA, V _{GS} =0V
Zero gate voltage drain current	I _{DSS}	—	—	10	μA	V _{DS} =100V, V _{GS} =0V
Gate threshold voltage	V _{GS(th)}	1.0	—	2.5	V	V _{DS} =10V, I _D =1mA
Static drain-source on-state resistance	R _{DS(on)}	—	0.18	0.22	Ω	I _D =2.5A, V _{GS} =10V
		—	0.25	0.28		I _D =2.5A, V _{GS} =4V
Forward transfer admittance	Y _{fs} *	4.0	—	—	S	I _D =2.5A, V _{DS} =10V
Input capacitance	C _{iss}	—	520	—	pF	V _{DS} =10V
Output capacitance	C _{oss}	—	175	—	pF	V _{GS} =0V
Reverse transfer capacitance	C _{rss}	—	60	—	pF	f=1MHz
Turn-on delay time	t _{d(on)}	—	5.0	—	ns	I _D =2.5A, V _{DD} ≐50V
Rise time	t _r	—	20	—	ns	V _{GS} =10V
Turn-off delay time	t _{d(off)}	—	50	—	ns	R _L =20Ω
Fall time	t _f	—	20	—	ns	R _G =10Ω

* Pw≦300 μs, Duty cycle≦1%

●Electrical characteristic curves

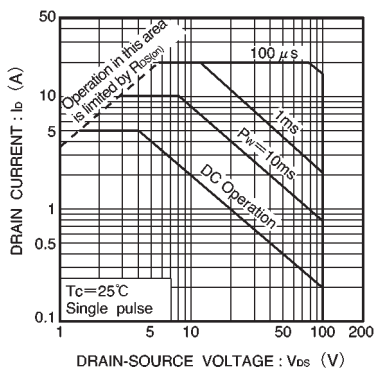


Fig.1 Maximum safe operating area

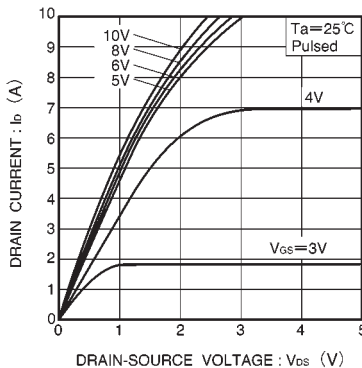


Fig.2 Typical output characteristics

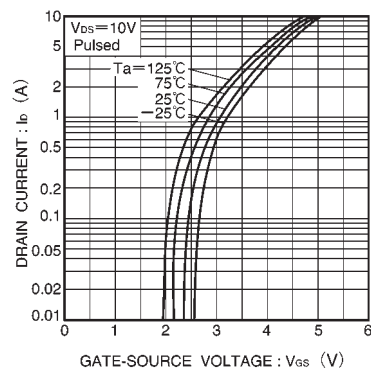


Fig.3 Typical transfer characteristics

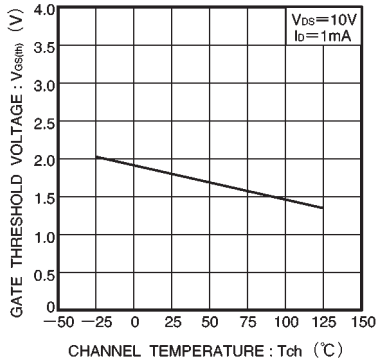


Fig.4 Gate threshold voltage vs. channel temperature

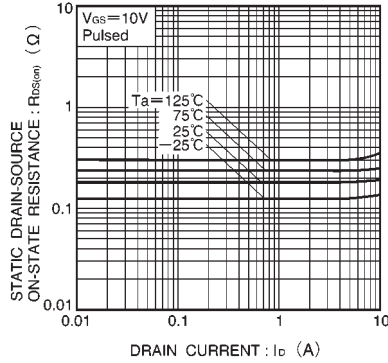


Fig.5 Static drain-source on-state resistance vs. drain current (I)

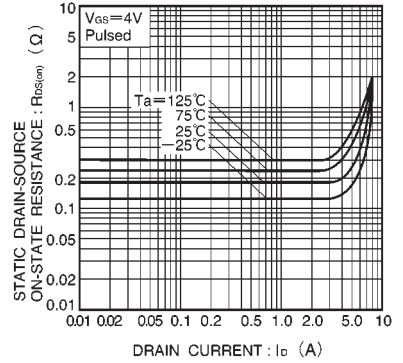


Fig.6 Static drain-source on-state resistance vs. drain current (II)

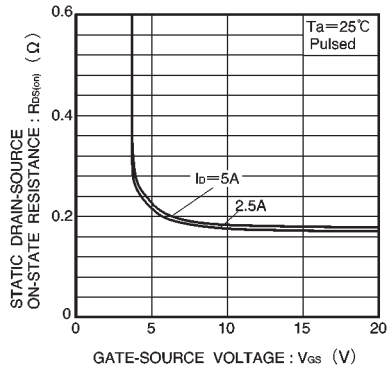


Fig.7 Static drain-source on-state resistance vs. gate-source voltage

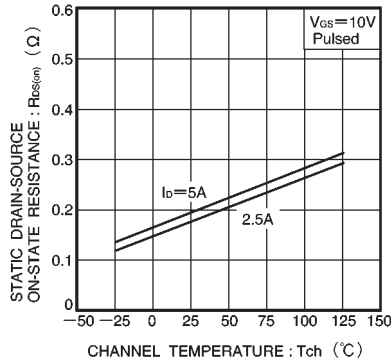


Fig.8 Static drain-source on-state resistance vs. channel temperature

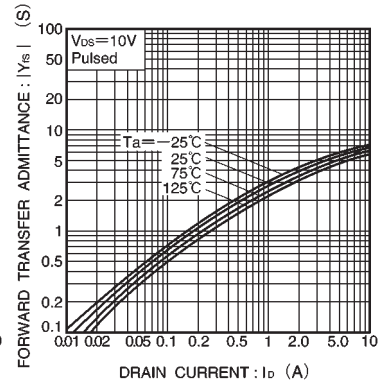


Fig.9 Forward transfer admittance vs. drain current

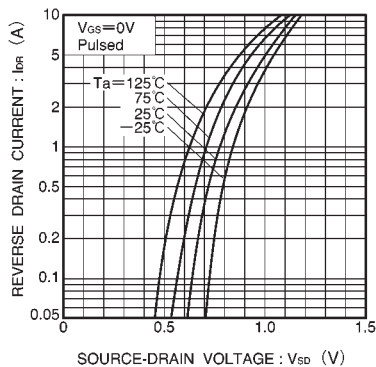


Fig.10 Reverse drain current vs. source-drain voltage (I)

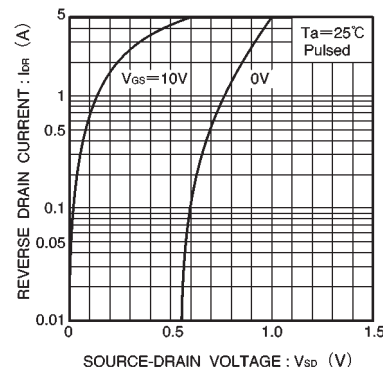


Fig.11 Reverse drain current vs. source-drain voltage (II)

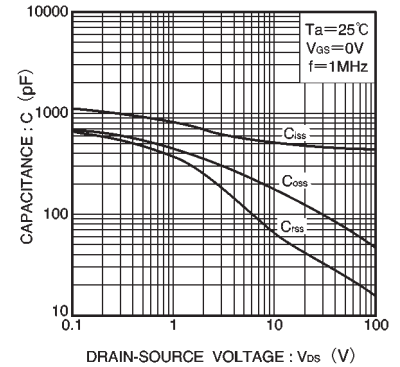


Fig.12 Typical capacitance vs. drain-source voltage

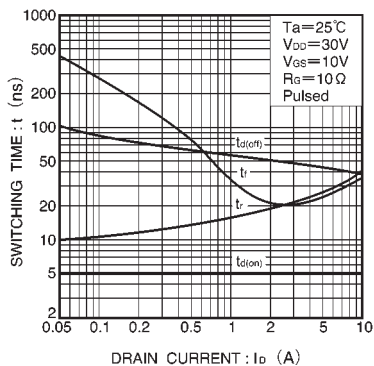


Fig.13 Switching characteristics
(See Figures 16 and 17 for the measurement circuit and resultant waveforms)

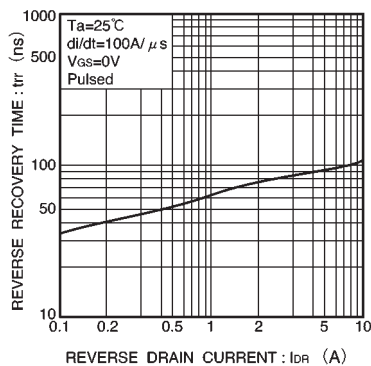


Fig.14 Reverse recovery time
vs. reverse drain current

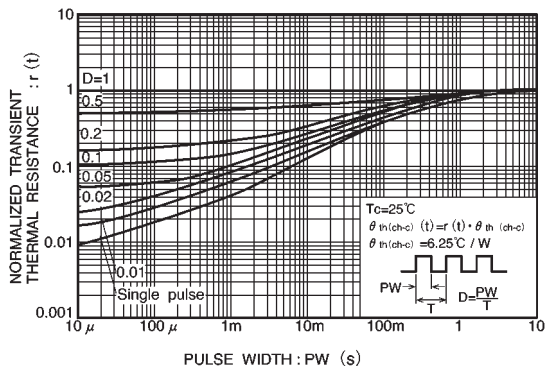


Fig.15 Normalized transient thermal
resistance vs. pulse width

● Switching characteristics measurement circuit

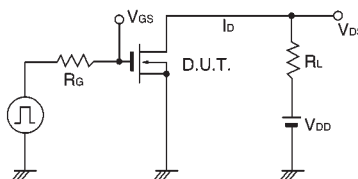


Fig.16 Switching time measurement circuit

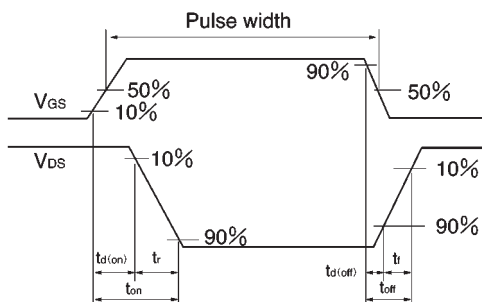


Fig.17 Switching time waveforms